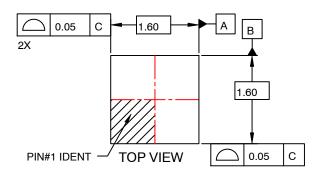
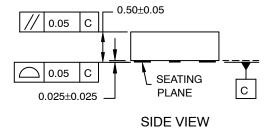
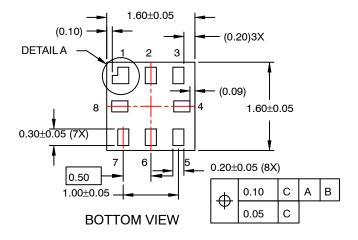
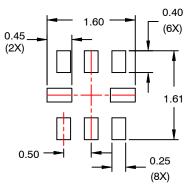
UQFN8 1.6X1.6, 0.5P CASE 523AY ISSUE O

**DATE 31 AUG 2016** 





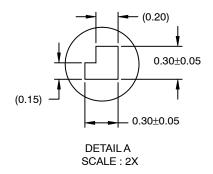




RECOMMENDED LAND PATTERN

## NOTES:

- A. PACKAGE CONFORMS TO JEDEC MO-255 VARIATION UAAD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.



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